SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

- D-Type Flip-Flops in a Single Package With 3-State Bus Driving True Outputs
- Full Parallel Access for Loading
- Buffered Control Inputs
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

description

These octal D-type edge-triggered flip-flops feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

A buffered output-enable (\overline{OE}) input places the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without interface or pullup components.

	(TO	P VI	EW)	
<u>OE</u> [σ	20] V _{CC}] 8Q
1Q [1D [2 3		19 18] 8D
2D [4		17] 7D
2Q [5		16] 7Q
3Q [3D [6 7		15 14] 6Q] 6D
4D [8		13] 5D
4Q [9		12] 5Q
GND [10		11] CLK

SN54ALS374A, SN54AS374...J PACKAGE

SN74ALS374A, SN74AS374 . . . DW OR N PACKAGE

SN54ALS374A, SN54AS374...FK PACKAGE (TOP VIEW)

	10 0 <u>6</u> 00 8 0 8	
2D		8D
2Q	5 17	7D
2D 2Q 3Q 3D 4D	6 16	7Q
3D	7 15	6Q
4D	8	6D
	50 CLK	

OE does not affect internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54ALS374A and SN54AS374 are characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ALS374A and SN74AS374 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each flip-flop)									
INPUTS		OUTPUT							
CLK	D	Q							
\uparrow	Н	Н							
\uparrow	L	L							
H or L	Х	Q ₀							
Х	Х	Z							
	(each f INPUTS CLK ↑ ↑ H or L	(each flip-flop INPUTS CLK D ↑ H ↑ L H or L X							



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

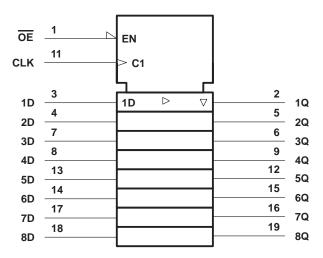
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



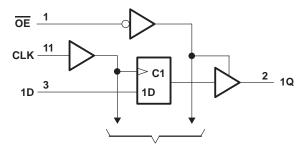
Copyright © 1999, Texas Instruments Incorporated On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

SDAS167C – APRIL 1982 – REVISED NOVEMBER 1999

logic symbol[†]



logic diagram (positive logic)



To Seven Other Channels

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V ₁	–0.5 V to 7 V
Voltage applied to a disabled 3-state output	–0.5 V to 5.5 V
Package thermal impedance, θ _{JA} (see Note 1): DW package	58°C/W
N package	69°C/W
Storage temperature range, T _{stg}	. −65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

		SN54ALS374A		SN7	'4A	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-1			-2.6	mA
IOL	Low-level output current			12			24	mA
Т _А	Operating free-air temperature	-55		125	0		70	°C



SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

DADAMETED	TEST CONDITIONS		SN5	SN54ALS374A			SN74ALS374A			
PARAMETER	TEST CC	INDITIONS	MIN	TYP†	MAX	MIN	түр†	MAX	UNIT	
VIK	V _{CC} = 4.5 V,	lı = -18 mA			-1.5			-1.5	V	
	V _{CC} = 4.5 V to 5.5 V,	I _{OH} = -0.4 mA	V _{CC} -2			V _{CC} -2				
VOH	V _{CC} = 4.5 V	$I_{OH} = -1 \text{ mA}$	2.4	3.3					V	
	$v_{\rm CC} = 4.5 v$	I _{OH} = -2.6 mA				2.4	3.2			
Ve	V _{CC} = 4.5 V	I _{OL} = 12 mA		0.25	0.4		0.25	0.4	V	
VOL		I _{OL} = 24 mA					0.35	0.5	v	
IOZH	V _{CC} = 5.5 V,	V _O = 2.7 V			20			20	μA	
IOZL	V _{CC} = 5.5 V,	$V_{O} = 0.4 V$			-20			-20	μΑ	
lj	V _{CC} = 5.5 V,	$V_{I} = 7 V$			0.1			0.1	mA	
Iн	V _{CC} = 5.5 V,	VI = 2.7 V			20			20	μΑ	
١ _{١L}	V _{CC} = 5.5 V,	VI = 0.4 V			-0.2			-0.2	mA	
10‡	V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA	
		Outputs high		11	20		11	19		
ICC	V _{CC} = 5.5 V	Outputs low		19	28		19	28	mA	
		Outputs disabled		20	31		20	31		

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. [‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

			SN54ALS374A		SN74AL	UNIT	
					MIN	MAX	UNIT
fclock	Clock frequency			30		35	MHz
tw	Pulse duration	CLK high or low	16.5		14		ns
t _{su}	Setup time	Data before CLK↑	10		10		ns
th	Hold time	Data after CLK↑	4		0		ns

switching characteristics over recommended operating conditions (unless otherwise noted (see Figure 3)

PARAMETER	FROM	то	SN54ALS374A		SN74AL	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	
fmax			30		35		MHz
^t PLH	CLK	0	3	14	3	12	ns
^t PHL		Q	5	17	5	16	115
^t PZH	OE	0	3	18	3	17	ns
^t PZL	ÛE	Q	5	21	5	18	115
^t PHZ	ŌĒ	Q	1	11	1	10	
^t PLZ	UE	Q	2	19	2	18	ns



SDAS167C – APRIL 1982 – REVISED NOVEMBER 1999

recommended operating conditions

		SN54AS374		'4	SI	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-12			-15	mA
IOL	Low-level output current			32			48	mA
ТА	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST OF	NDITIONS	SN	154AS374	4	SN	UNIT		
PARAMETER	TEST CC	TEST CONDITIONS		TYP†	MAX	MIN	TYP†	MAX	UNIT
VIK	V _{CC} = 4.5 V,	lı = -18 mA			-1.2			-1.2	V
	V _{CC} = 4.5 V to 5.5 V,	$I_{OH} = -2 \text{ mA}$	V _{CC} -2			V _{CC} -2			
VOH	V _{CC} = 4.5 V	I _{OH} = -12 mA	2.4	3.2					V
	VCC = 4.5 V	I _{OH} = -15 mA				2.4	3.3		
Va	$V_{CC} = 4.5 V$	I _{OL} = 32 mA		0.29	0.5				V
V _{OL} V _{CC} =	$v_{CC} = 4.5 v$	I _{OL} = 48 mA					0.34	0.5	v
I _{OZH}	V _{CC} = 5.5 V,	V _O = 2.7 V			50			50	μΑ
I _{OZL}	V _{CC} = 5.5 V,	$V_{O} = 0.4 V$			-50			-50	μΑ
lj	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA
IIH	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μA
OE, CLK					-0.5			-0.5	
I _{IL} Data	$V_{CC} = 5.5 V,$	$V_{I} = 0.4 V$			-3			-2	mA
IO‡	V _{CC} = 5.5 V,	V _O = 2.25 V	-30		-112	-30		-112	mA
		Outputs high		77	120		77	120	
ICC	V _{CC} = 5.5 V	Outputs low		84	128		84	128	mA
		Outputs disabled		84	128		84	128	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡]The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

			SN54AS374		SN74A	UNIT		
			MIN	MAX	MIN	MAX	UNIT	
fclock	Clock frequency	-		100*		125	MHz	
	Pulse duration	CLK high	5.5*		4			
tw		CLK low	3*		3		ns	
t _{su}	Setup time	Data before CLK [↑]	3*		2		ns	
th	Hold time	Data after CLK1	3*		2		ns	

* On products compliant to MIL-PRF-38535, this parameter is not production tested.



SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

switching characteristics over recommended operating conditions (unless otherwise noted) (see Figure 3)

PARAMETER	FROM	то	SN54AS374		SN74A	UNIT	
FARAIVIETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT
f _{max}			100*		125		MHz
^t PLH	CLK	0	3	11	3	8	20
^t PHL		Q	4	11.5	4	9	ns
^t PZH	OE	0	2	7	2	6	20
^t PZL	UE UE	Q	3	11	3	10	ns
^t PHZ	OE	Q	2	10	2	6	ns
^t PLZ			2	7	2	6	115

* On products compliant to MIL-PRF-38535, this parameter is not production tested.



SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

APPLICATION INFORMATION

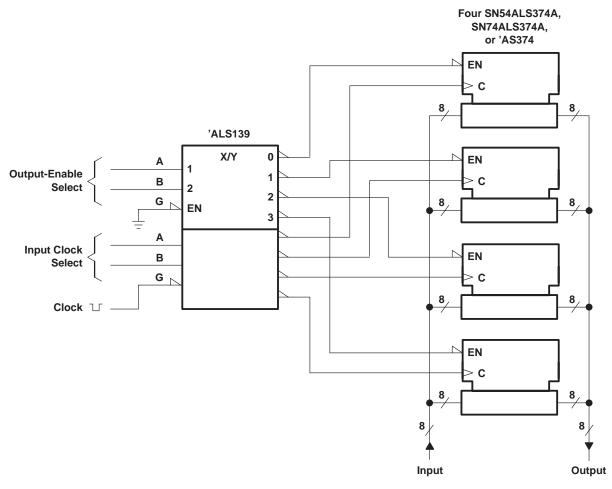
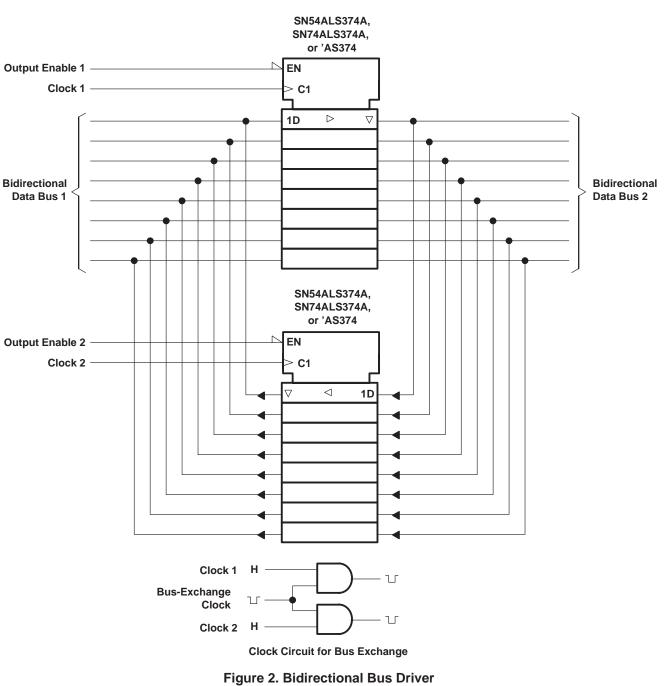


Figure 1. Expandable 4-Word by 8-Bit General File Register



SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

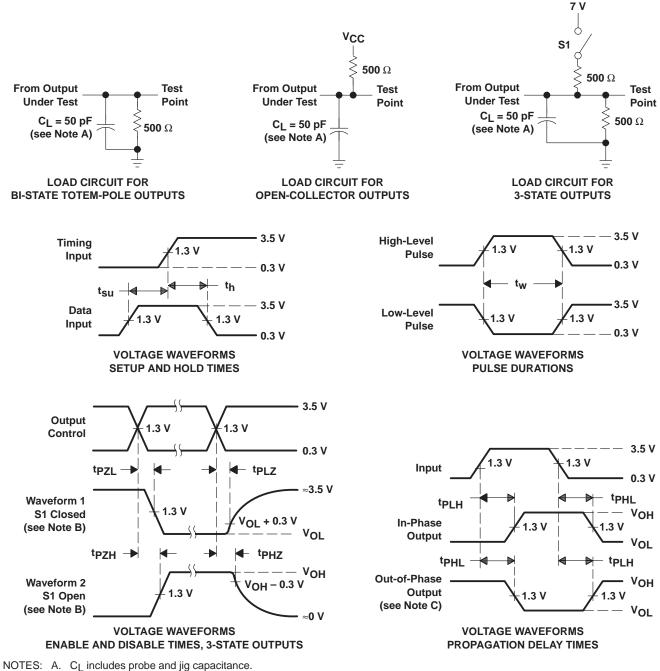


APPLICATION INFORMATION



SDAS167C - APRIL 1982 - REVISED NOVEMBER 1999

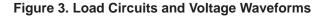
PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.

Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. When measuring propagation delay items of 3-state outputs, switch S1 is open.

- D. All input pulses have the following characteristics: $PRR \le 1$ MHz, $t_{f} = t_{f} = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.





IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1999, Texas Instruments Incorporated